MOSFET – Power, Single, N-Channel, μ8FL 30 V, 79 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Low-Side DC-DC Converters
- Power Load Switch
- Notebook Battery Management
- Motor Control

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Param	eter		Symbol	Value	Unit
Drain-to-Source Voltage		V_{DSS}	30	V	
Gate-to-Source Voltage	o–Source Voltage			±20	V
Continuous Drain		T _A = 25°C	I _D	18	Α
Current R _{θJA} (Note 1)		T _A = 85°C		13	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.2	W
Continuous Drain		T _A = 25°C	I _D	25.5	Α
Current R _{θJA} ≤ 10 s (Note 1)		T _A = 85°C		18.5	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	4.5	W
Continuous Drain	State	T _A = 25°C	Ι _D	11	Α
Current R _{θJA} (Note 2)		T _A = 85°C	1	8.0	1
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	0.85	W
Continuous Drain		T _C = 25°C	Ι _D	79	Α
Current R _{θJC} (Note 1)		T _C = 85°C	1	57	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	43	W
Pulsed Drain Current	$T_A = 25^{\circ}$	C, t _p = 10 μs	I_{DM}	235	Α
Operating Junction and S	torage Ten	nperature	T _J , T _{stg}	-55 to +150	°C
Source Current (Body Did	Source Current (Body Diode)				
Drain to Source dV/dt	dV/dt	6.0	V/ns		
$(T_J = 25^{\circ}C, V_{DD} = 50 \text{ V}, \text{ V}$	Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, V_{DD} = 50 V, V_{GS} = 10 V, I_L = 43 A_{pk} , L = 0.1 mH, R_G = 25 Ω)				mJ
Lead Temperature for So (1/8" from case for 10 s)	dering Pur	poses	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

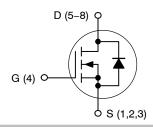


ON Semiconductor®

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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	4.0 mΩ @ 10 V	79 A
30 V	5.5 mΩ @ 4.5 V	191

N-Channel MOSFET





WDFN8 (μ8FL) CASE 511AB



4932 = Specific Device Code
A = Assembly Location
Y = Year

Y = Year WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4932NTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NTTFS4932NTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.9	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	56.5	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	147.6	
Junction–to–Ambient – (t ≤ 10 s) (Note 3)	$R_{ hetaJA}$	27.5	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size (40 mm², 1 oz. Cu).

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D =$	= 250 μA	30			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				14		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		$V_{GS} = 0 V$, $V_{DS} = 24 V$	T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	_s = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.2	1.6	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}		I _D = 20 A		2.5	4.0	mΩ
		V _{GS} = 10 V	I _D = 10 A		2.5		7
			I _D = 20 A		3.6	5.5	
		V _{GS} = 4.5 V	I _D = 10 A		3.6		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _I	_O = 15 A		46		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}				3111		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 15 V			1064		7
Reverse Transfer Capacitance	C _{rss}				42		
Total Gate Charge	Q _{G(TOT)}				20		nC
Threshold Gate Charge	Q _{G(TH)}	451/1/	15.)/ L 00.A		4.9		
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 7$	15 V, I _D = 20 A		8.9		
Gate-to-Drain Charge	Q_{GD}				3.3		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 20 A			46.5		nC
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t _{d(on)}				15.5		ns
Rise Time	t _r	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			22.6		
Turn-Off Delay Time	t _{d(off)}				29		
Fall Time	t _f				4.8		

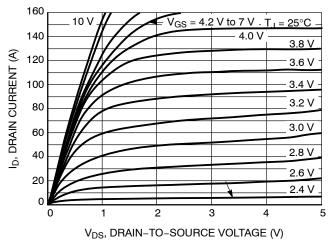
- 5. Pulse Test: pulse width = 300 $\mu s,$ duty cycle \leq 2%.
- 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condit	ion	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS	S (Note 6)		•			•	
Turn-On Delay Time	t _{d(on)}				11		ns
Rise Time	t _r	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			21.5		1
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 \text{ A}, R_G =$	3.0 Ω		35.6		1
Fall Time	t _f		•		3.5		1
DRAIN-SOURCE DIODE CHARA	ACTERISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		8.0	1.1	V
			T _J = 125°C		0.7		
Reverse Recovery Time	t _{RR}		•		40		ns
Charge Time	t _a	V_{GS} = 0 V, d_{IS}/d_t = 100 A/ μ s, I_S = 20 A			21		
Discharge Time	t _b				19		
Reverse Recovery Charge	Q _{RR}				37.5		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				0.38		nΗ
Drain Inductance	L _D	T 0500			0.054		1
Gate Inductance	L _G	T _A = 25°C			1.3		1
Gate Resistance	R_{G}				1.1	2.0	Ω

^{5.} Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

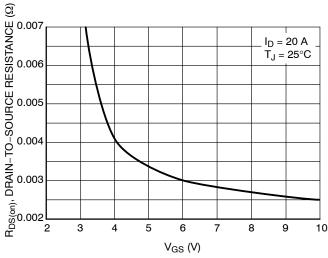
TYPICAL CHARACTERISTICS



120 $V_{DS} \ge 10 \text{ V}$ 100 ID, DRAIN CURRENT (A) 80 60 $T_J = 25^{\circ}C$ 40 20 T_J = 125°C $T_J = -55^{\circ}C$ 0 1.0 1.5 2.0 2.5 3.0 3.5 4.0 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



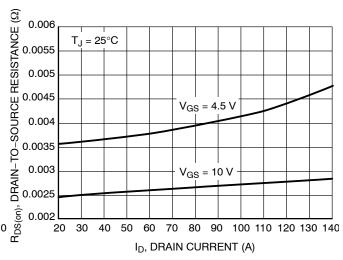
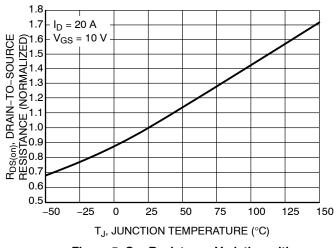


Figure 3. On-Resistance vs. V_{GS}

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



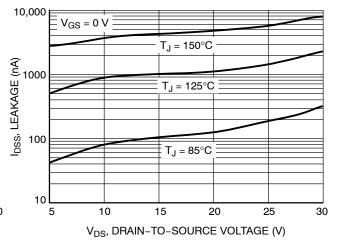


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

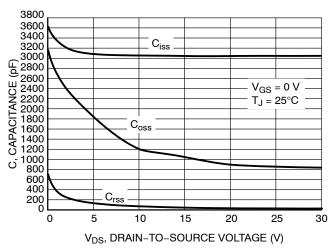


Figure 7. Capacitance Variation

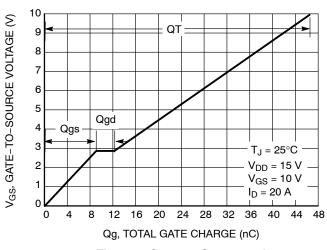


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

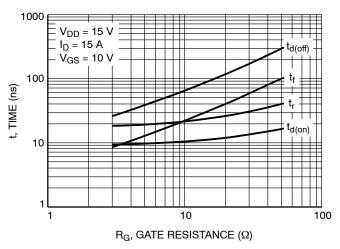


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

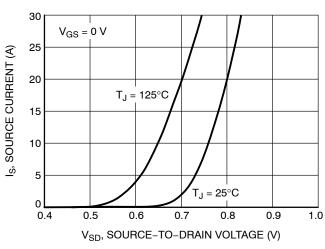


Figure 10. Diode Forward Voltage vs. Current

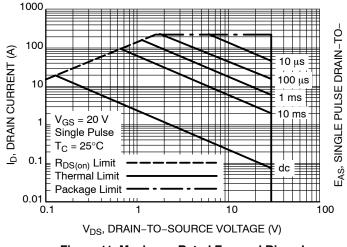


Figure 11. Maximum Rated Forward Biased Safe Operating Area

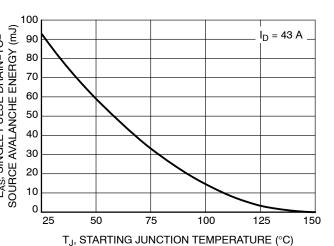


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

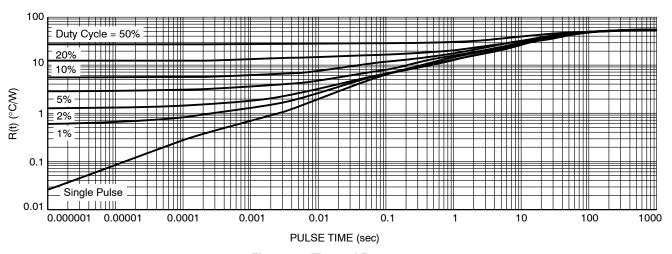


Figure 13. Thermal Response

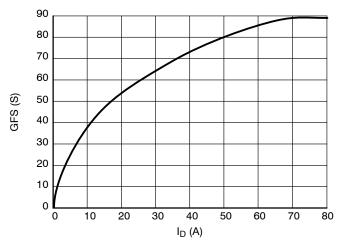


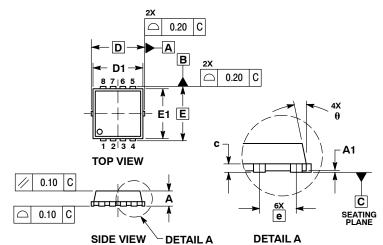
Figure 14. GFS vs. I_D





WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

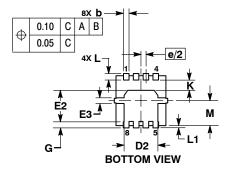
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NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MI	LLIMETE	RS		INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0)	
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC		(0.026 BS0	2
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
M	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

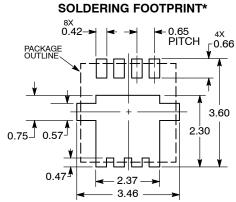


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code Α = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1

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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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